## Search Notes



Application/Control No.

Applicant(s)/Patent under Reexamination
IKENAGA ET AL.

10/697,701

Examiner

2141

Art Unit

Quang N. Nguyen

SEARCHED				
Class	Subclass	Date	Examiner	
709	203	4/26/2007	QN	
709	223	4/26/2007	QN	
709	224	4/26/2007	QN	
705	39	4/26/2007	QN	
705	60	4/26/2007	QN	
709	217	10/4/2007	QN	
709	218	10/4/2007	QN	
709	224	10/4/2007	QN	
709	. 226	10/4/2007	QN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
709	203	10/4/2007	QN	
709	217	10/4/2007	QN	
709	218	10/4/2007	QN	
709/224, 226		10/4/2007	QN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search	4/25/2006	QN		
East Search (see notes)	4/26/2007	QN		
East Search (see notes)	10/4/2007	QN		
IEEE Search (see notes)	10/4/2007	QN		
Google Search (see notes)	10/4/2007	QN		
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